

MC3487 Quadruple Differential Line Driver

1 Features

- Meets or exceeds requirements of ANSI TIA/EIA-422-B and ITU recommendation V.11
- 3-state, TTL-compatible outputs
- Fast transition times
- High-impedance inputs
- Single 5V supply
- Power-up and power-down protection

2 Applications

- [Factory automation](#)
- ATM and cash counters
- [Smart grid](#)
- AC and [servo motor](#) drives

3 Description

The MC3487 offers four independent differential line drivers designed to meet the specifications of ANSI TIA/EIA-422-B and ITU Recommendation V.11. Each driver has a TTL compatible input buffered to reduce current and minimize loading.

The driver outputs uses 3-state circuitry to provide high-impedance states at any pair of differential outputs when the appropriate output enable is at a low logic level. Internal circuitry is provided a high-impedance state at the differential outputs during power-up and power-down transition times, provided the output enable is low.

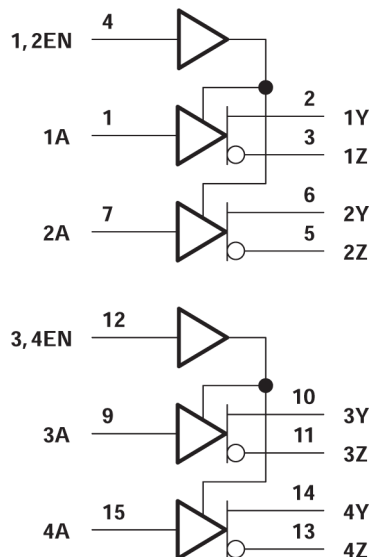
The MC3487 is designed for best performance when used with the MC3486 quadruple line receiver. The device is available in a 16-pin dual-in-line package and operates from a single 5V supply.

Package Information

PART NUMBER	PACKAGE ⁽¹⁾	PACKAGE SIZE ⁽²⁾
MC3486	D (SOIC, 16)	19.3mm × 9.4mm
	N (PDIP, 16)	19.3mm × 9.4mm
	NS (SOP, 16)	10.2mm × 7.8mm

(1) For more information, see [Section 10](#).

(2) The package size (length × width) is a nominal value and includes pins, where applicable.



Logic Diagram (Positive Logic)



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4 Pin Configuration and Functions

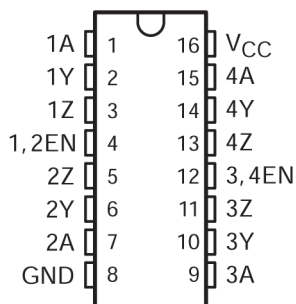


Figure 4-1. D, N, or NS Package (Top View)

Table 4-1. Pin Functions

PIN		TYPE ⁽¹⁾	DESCRIPTION
NAME	NO.		
1A	1	I	Single Ended Data Input for Channel 1
1Y	2	O	Non-Inverting Output for Differential Driver on Channel 1
1Z	3	O	Inverting Output of Differential Driver on Channel 1
1,2EN	4	I	Enable Input for Channels 1 and 2
2Z	5	O	Inverting Output of Differential Driver on Channel 2
2Y	6	O	Non-Inverting Output for Differential Driver on Channel 2
2A	7	I	Single Ended Data Input for Channel 2
GND	8	GND	Device Ground
3A	9	I	Single Ended Data Input for Channel 3
3Y	10	O	Non-Inverting Output for Differential Driver on Channel 3
3Z	11	O	Inverting Output of Differential Driver on Channel 3
3,4EN	12	I	Enable Input for Channels 3 and 4
4Z	13	O	Inverting Output of Differential Driver on Channel 4
4Y	14	O	Non-Inverting Output for Differential Driver on Channel 4
4A	15	I	Single Ended Data Input for Channel 4
V _{CC}	16	P	5V Power Supply Positive Terminal Connection

(1) Signal Types: I = Input, O = Output, I/O = Input or Output, P = Power, GND = Ground.

5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
V_{CC} (see ⁽²⁾)	Supply voltage		7	V
V_I	Input voltage		5.5	V
V_O	Output voltage		7	V
T_J	Operating virtual junction temperature		150	°C
T_{stg}	Storage temperature range	–65	150	°C

- (1) Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values, except differential output voltage, V_{OD} , are with respect to the network ground terminal.

5.2 Recommended Operating Conditions

		MIN	NOM	MAX	UNIT
V_{CC}	Supply voltage	4.75	5	5.25	V
V_{IH}	High-level input voltage	2			V
V_{IL}	Low-level input voltage			0.8	V
T_A	Operating free-air temperature	0		70	°C

5.3 Thermal Information

THERMAL METRIC ⁽¹⁾		D (SOIC)	N (PDIP)	NS (SOP)	UNIT
		16-PINS			
R _{θJA}	Junction-to-ambient thermal resistance	84.6	60.6	88.5	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	43.5	48.1	46.2	°C/W
R _{θJB}	Junction-to-board thermal resistance	43.2	40.6	50.7	°C/W
ψ _{JT}	Junction-to-top characterization parameter	10.4	27.5	13.5	°C/W
ψ _{JB}	Junction-to-board characterization parameter	42.8	40.3	50.3	°C/W
R _{θJC(bot)}	Junction-to-case (bottom) thermal resistance	N/A	N/A	N/A	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC package thermal metrics](#) application report.

5.4 Electrical Characteristics

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS			MIN	MAX	UNIT
V _{IK}	Input clamp voltage	I _I = -18 mA				-1.5	V
V _{OH}	High-level output voltage	V _{IL} = 0.8 V,	V _{IH} = 2 V,	I _{OH} = -20 mA	2.5		V
V _{OL}	Low-level output voltage	V _{IL} = 0.8 V,	V _{IH} = 2 V,	I _{OL} = 48 mA		0.5	V
V _{OD}	Differential output voltage	R _L = 100 Ω	See Figure 6-1		2		
Δ V _{OD}	Change in magnitude of differential output voltage ⁽¹⁾	R _L = 100 Ω	See Figure 6-1			±0.4	V
V _{OC}	Common-mode output voltage ⁽²⁾	R _L = 100 Ω	See Figure 6-1			3	V
Δ V _{OC}	Change in magnitude of common-mode output voltage ⁽¹⁾	R _L = 100 Ω	See Figure 6-1			±0.4	V
I _O	Output current with power off	V _{CC} = 0	V _O = 6 V			100	μA
			V _O = -0.25 V			-100	
I _{OZ}	High-impedance-state output current	Output enables at 0.8 V	V _O = 2.7 V			100	μA
			V _O = 0.5 V			-100	
I _I	Input current at maximum input voltage	V _I = 5.5 V				100	μA
I _{IH}	High-level input current	V _I = 2.7 V				50	μA
I _{IL}	Low-level input current	V _I = 0.5 V				-400	μA
I _{OS}	Short-circuit output current ⁽³⁾	V _I = 2 V			-40	-140	mA
I _{CC}	Supply current (all drivers)	Outputs disabled				105	mA
		Outputs enabled, No load				85	

(1) $\Delta|V_{OD}|$ and $\Delta|V_{OC}|$ are the changes in magnitude of V_{OD} and V_{OC} , respectively, that occur when the input is changed from a high level to a low level.

(2) In ANSI Standard TIA/EIA-422-B, V_{OC} , which is the average of the two output voltages with respect to ground, is called output offset voltage, V_{OS} .

(3) Only one output at a time should be shorted, and duration of the short circuit should not exceed one second.

5.5 Switching Characteristics

over recommended operating free-air temperature range, $V_{CC} = 5\text{ V}$

PARAMETER		TEST CONDITIONS		MIN	MAX	UNIT
t_{PLH}	Propagation delay time, low- to high-level output	$C_L = 15\text{ pF}$,	See Figure 6-2		20	ns
t_{PHL}	Propagation delay time, high- to low-level output				20	
t_{sk}	Skew time	$C_L = 15\text{ pF}$,	See Figure 6-2		6	ns
$t_{t(OD)}$	Differential-output transition time	$C_L = 15\text{ pF}$,	See Figure 6-3		20	ns
t_{PZH}	Output enable time to high level	$C_L = 50\text{ pF}$,	See Figure 6-4		30	ns
t_{PZL}	Output enable time to low level				30	
t_{PHZ}	Output disable time from high level	$C_L = 50\text{ pF}$,	See Figure 6-4		25	ns
t_{PLZ}	Output disable time from low level				30	

6 Parameter Measurement Information

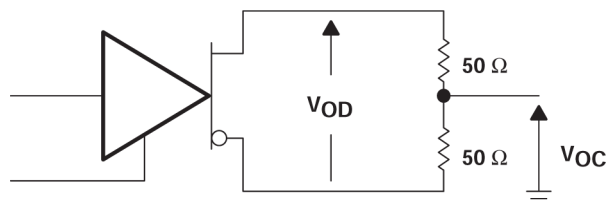
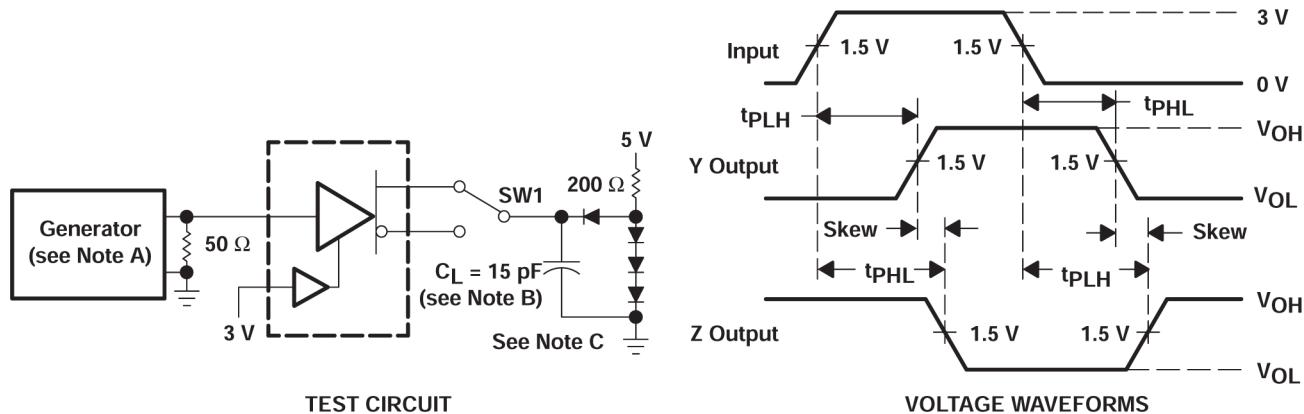
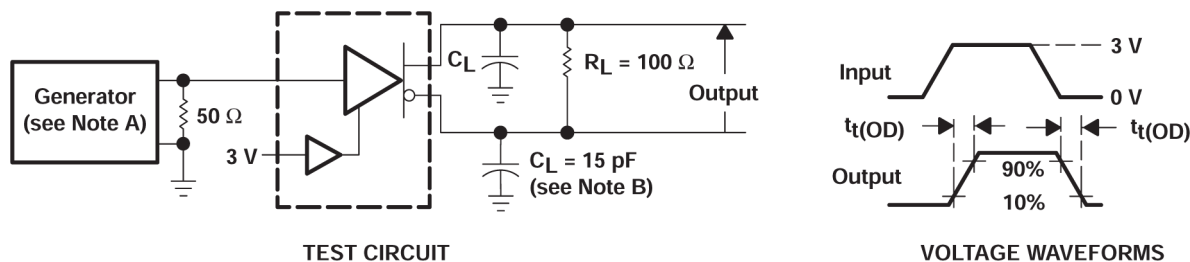


Figure 6-1. Differential and Common-Mode Output Voltages



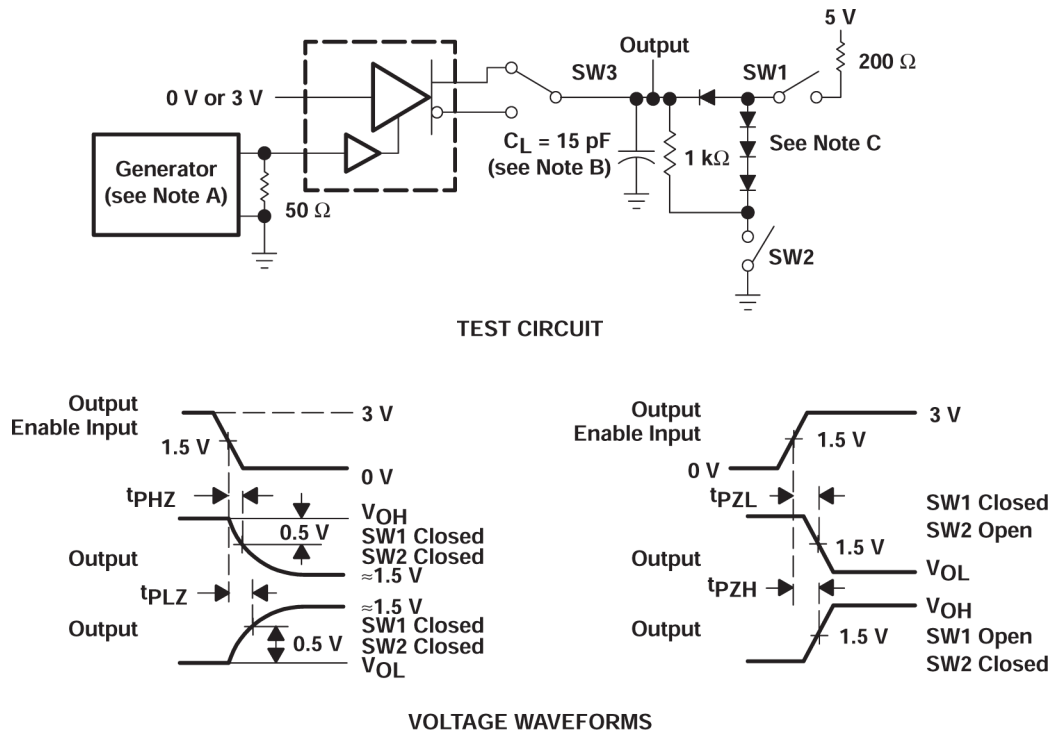
- A. The input pulse is supplied by a generator having the following characteristics: $t_r \leq 5$ ns, $t_f \leq 5$ ns, $PRR \leq 1$ MHz, duty cycle = 50% $Z_O = 50 \Omega$.
- B. C_L includes probe and stray capacitance.
- C. All diodes are 1N916 or 1N3064.

Figure 6-2. Test Circuit and Voltage Waveforms



- A. The input pulse is supplied by a generator having the following characteristics: $t_r \leq 5$ ns, $t_f \leq 5$ ns, $PRR \leq 1$ MHz, duty cycle = 50%, $Z_O = 50 \Omega$.
- B. C_L includes probe and stray capacitance.

Figure 6-3. Test Circuit and Voltage Waveforms



- A. The input pulse is supplied by a generator having the following characteristics: $t_r \leq 5 \text{ ns}$, $t_f \leq 5 \text{ ns}$, $\text{PRR} \leq 1 \text{ MHz}$, duty cycle = 50%, $Z_O = 50 \Omega$.
- B. C_L includes probe and stray capacitance.
- C. All diodes are 1N916 or 1N3064.

Figure 6-4. Driver Test Circuit and Voltage Waveforms

7 Device Functional Modes

Table 7-1. Function Table (Each Driver)

INPUT	OUTPUT ENABLE ⁽¹⁾	OUTPUTS	
		Y	Z
H	H	H	L
L	H	L	H
X	L	Z	Z

(1) H = TTL high level, L = TTL low level, X = irrelevant, Z = High impedance

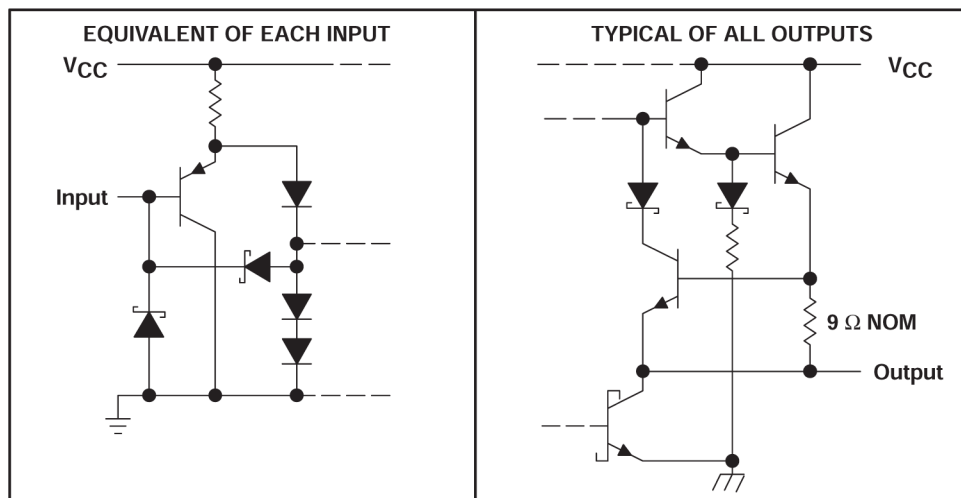


Figure 7-1. Schematics of Inputs and Outputs

8 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

8.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

8.2 Support Resources

[TI E2E™ support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

8.3 Trademarks

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8.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

8.5 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

9 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision C (February 2004) to Revision D (March 2024)	Page
• Changed the numbering format for tables, figures, and cross-references throughout the document.....	1

10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
MC3487D	Obsolete	Production	SOIC (D) 16	-	-	Call TI	Call TI	0 to 70	MC3487
MC3487DR	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	MC3487
MC3487DR.A	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	MC3487
MC3487N	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	MC3487N
MC3487N.A	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	MC3487N
MC3487NE4	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	MC3487N
MC3487NSR	Active	Production	SOP (NS) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	MC3487
MC3487NSR.A	Active	Production	SOP (NS) 16	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	MC3487

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

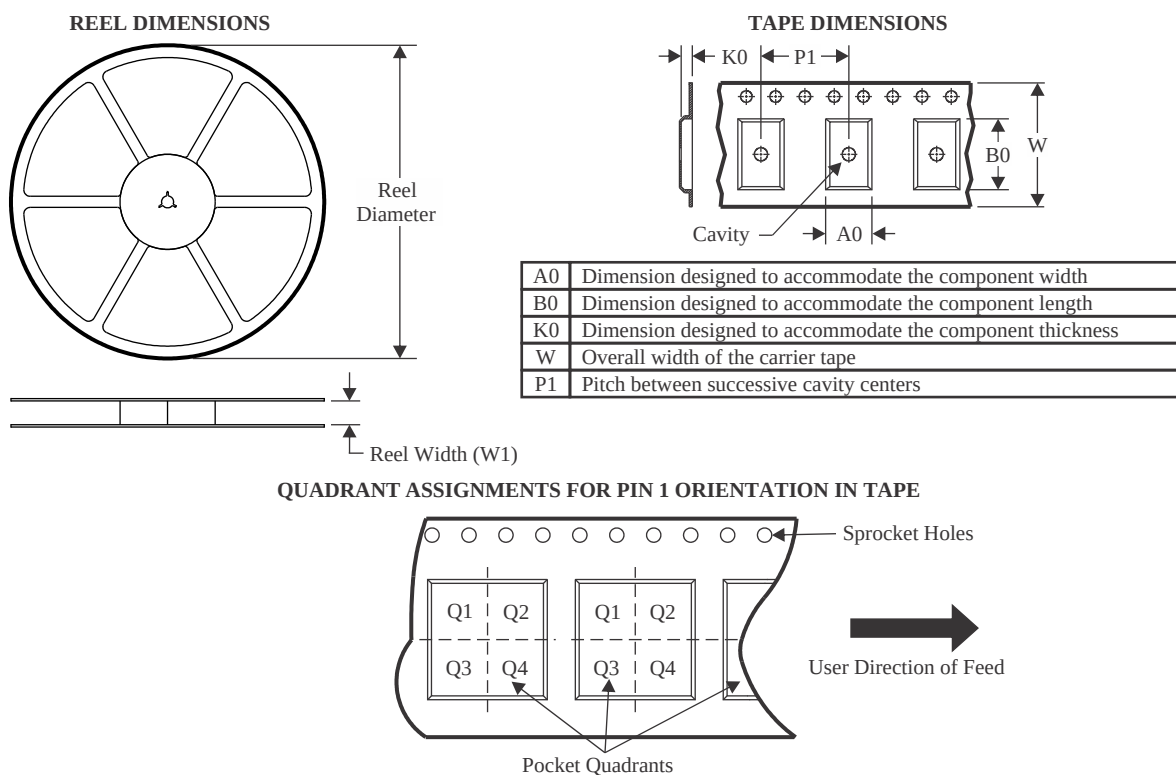
⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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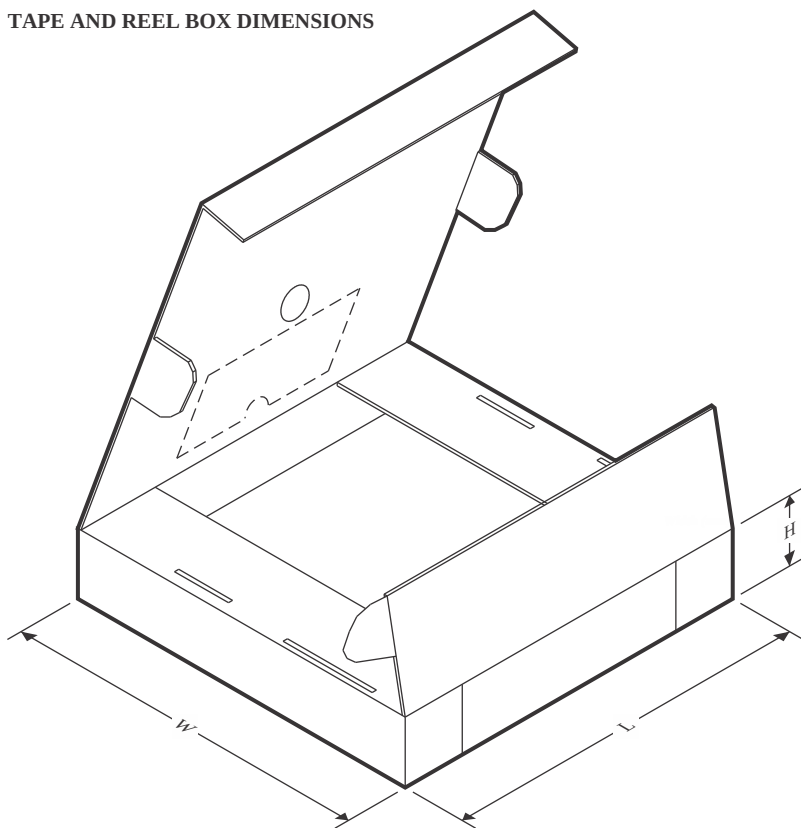
TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
MC3487DR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
MC3487DR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
MC3487NSR	SOP	NS	16	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1

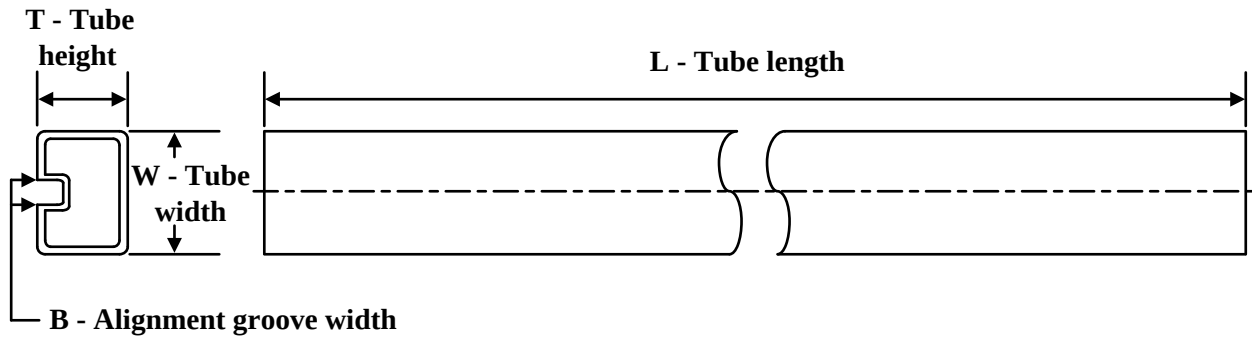
TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

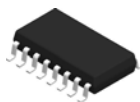
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
MC3487DR	SOIC	D	16	2500	340.5	336.1	32.0
MC3487DR	SOIC	D	16	2500	353.0	353.0	32.0
MC3487NSR	SOP	NS	16	2000	356.0	356.0	35.0

TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
MC3487N	N	PDIP	16	25	506	13.97	11230	4.32
MC3487N	N	PDIP	16	25	506	13.97	11230	4.32
MC3487N.A	N	PDIP	16	25	506	13.97	11230	4.32
MC3487N.A	N	PDIP	16	25	506	13.97	11230	4.32
MC3487NE4	N	PDIP	16	25	506	13.97	11230	4.32
MC3487NE4	N	PDIP	16	25	506	13.97	11230	4.32

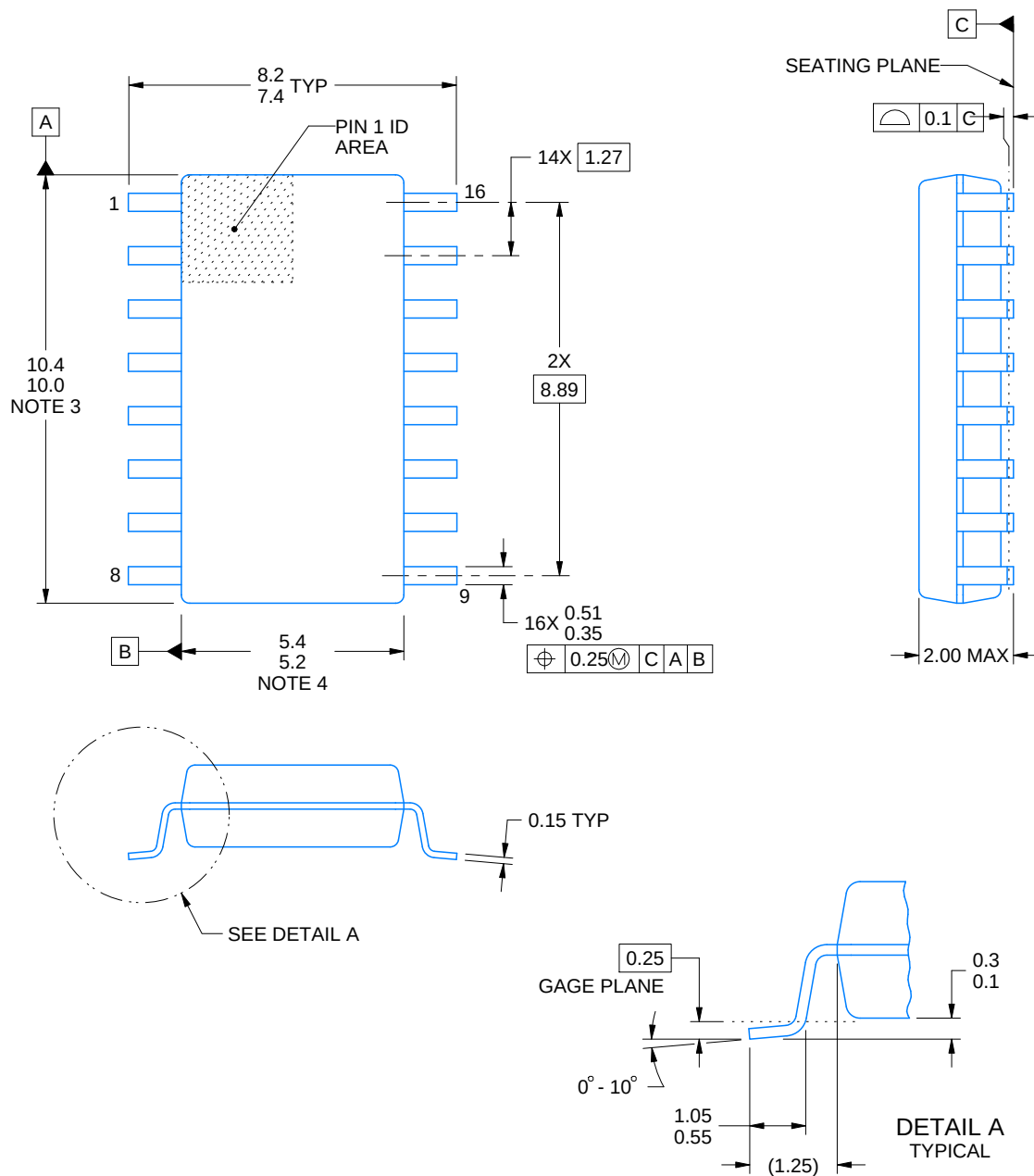


PACKAGE OUTLINE

NS0016A

SOP - 2.00 mm max height

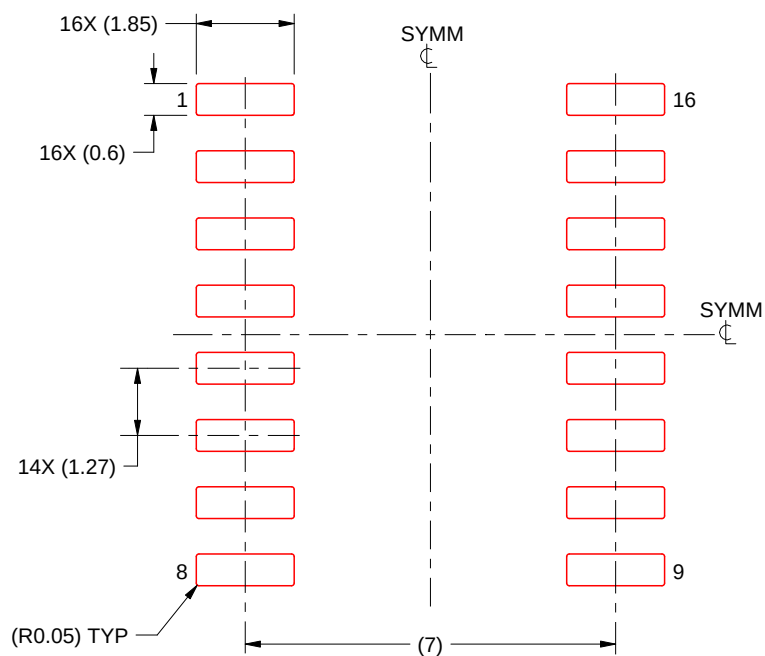
SOP



4220735/A 12/2021

NOTES:

1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.



SOLDER PASTE EXAMPLE
 BASED ON 0.125 mm THICK STENCIL
 SCALE:7X

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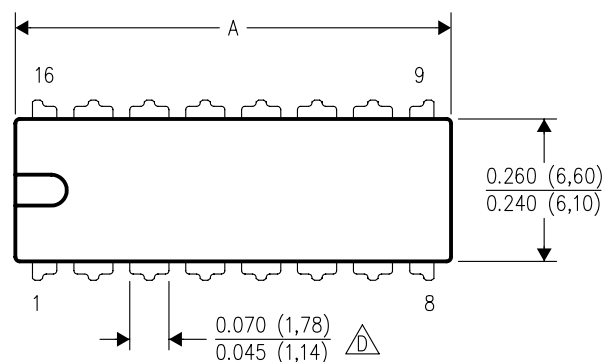
NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
8. Board assembly site may have different recommendations for stencil design.

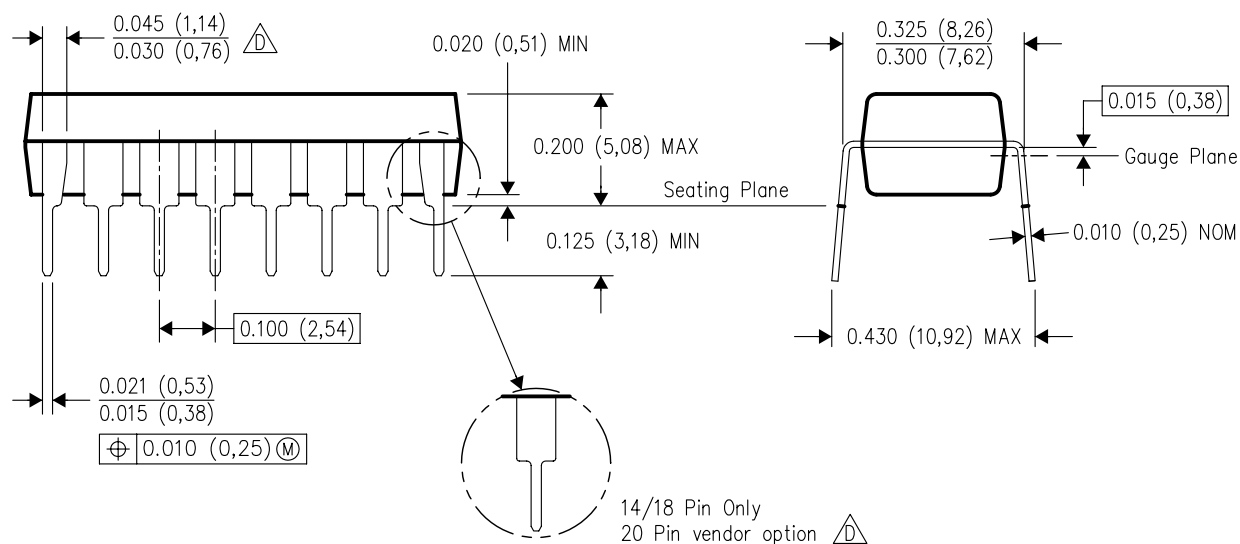
N (R-PDIP-T**)

16 PINS SHOWN

PLASTIC DUAL-IN-LINE PACKAGE



PINS **	14	16	18	20
DIM				
A MAX	0.775 (19,69)	0.775 (19,69)	0.920 (23,37)	1.060 (26,92)
A MIN	0.745 (18,92)	0.745 (18,92)	0.850 (21,59)	0.940 (23,88)
MS-001 VARIATION	AA	BB	AC	AD

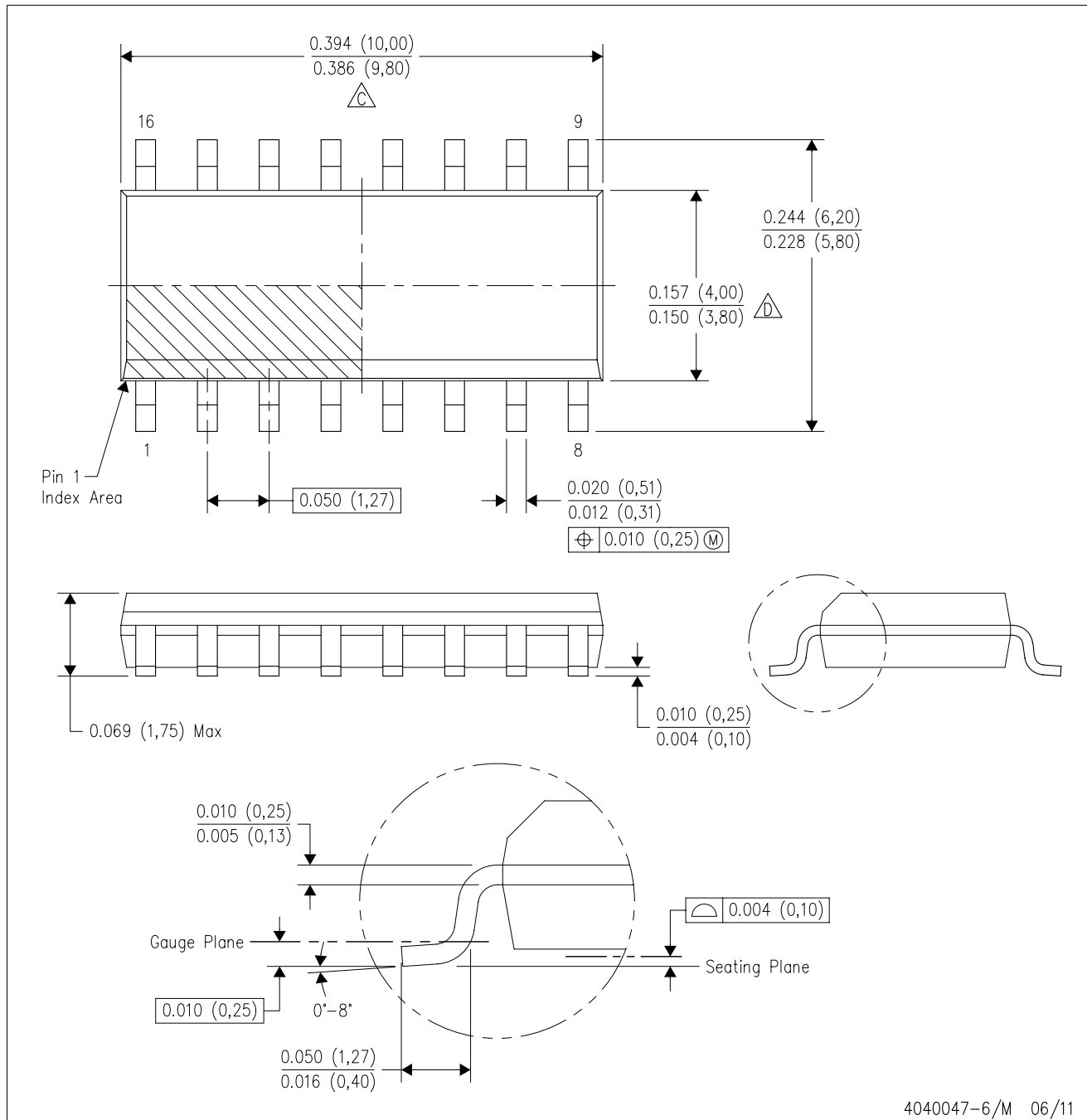


4040049/E 12/2002

- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
 - The 20 pin end lead shoulder width is a vendor option, either half or full width.

D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



4040047-6/M 06/11

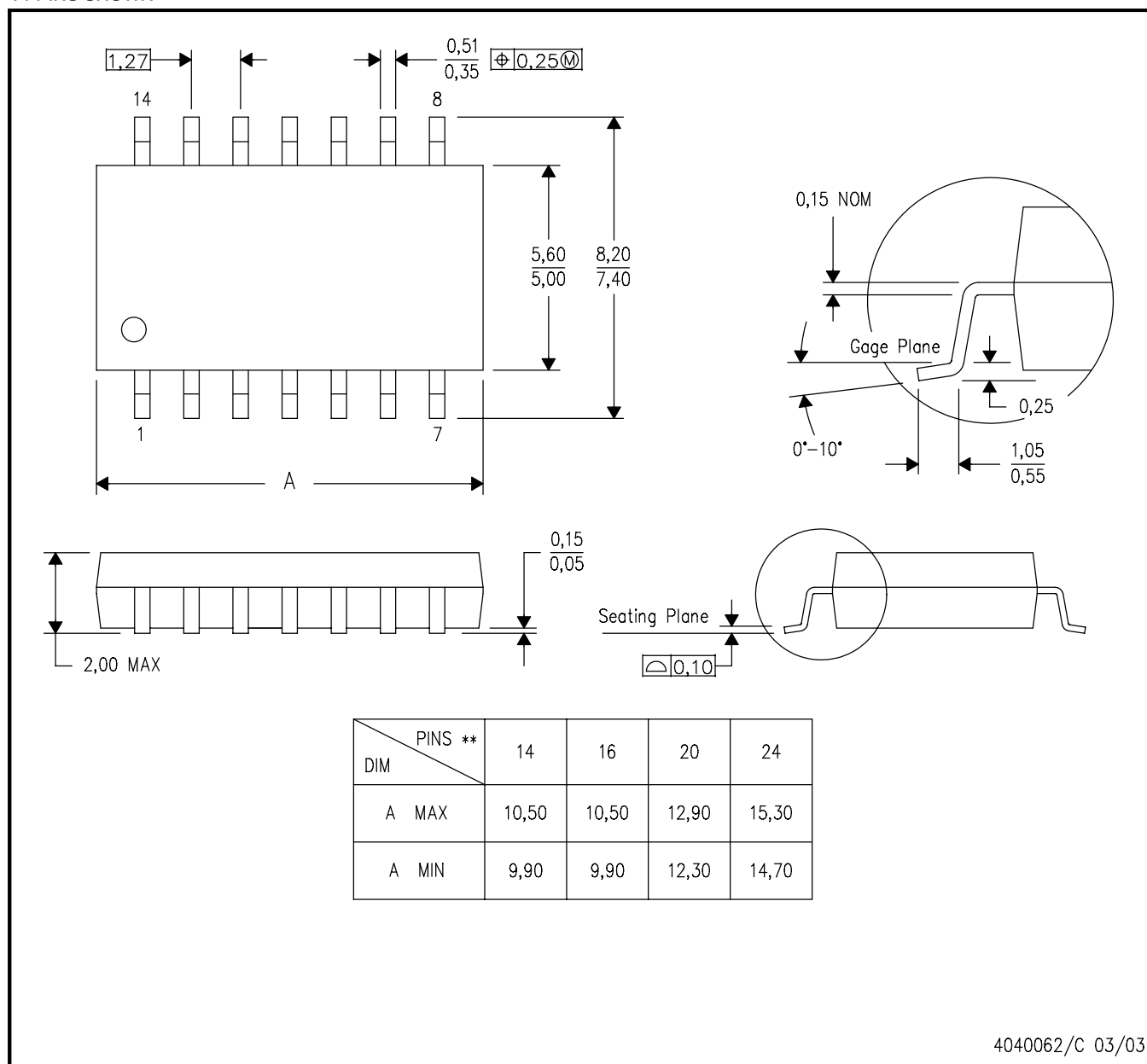
- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
 - D. Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
 - E. Reference JEDEC MS-012 variation AC.

MECHANICAL DATA

NS (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

14-PINS SHOWN



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.

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